## 74LV74

# Dual D-type flip-flop with set and reset; positive-edge trigger Rev. 3 — 9 September 2013 Product data sheet

## 1. General description

The 74LV74 is a dual positive edge triggered, D-type flip-flop. It has individual data (nD) inputs, clock (nCP) inputs, set (nSD) and (nRD) inputs, and complementary nQ and nQ outputs.

The set and reset are asynchronous active LOW inputs that operate independently of the clock input. Information on the data input is transferred to the nQ output on the LOW-to-HIGH transition of the clock pulse. The nD inputs must be stable one set-up time prior to the LOW-to-HIGH clock transition, for predictable operation. Schmitt-trigger action in the clock input makes the circuit highly tolerant to slower clock rise and fall times.

#### 2. Features and benefits

- Wide supply voltage range from 1.0 V to 5.5 V
- Optimized for low voltage applications: 1.0 V to 3.6 V
- Direct interface with TTL levels (2.7 V to 3.6 V)
- ESD protection:
  - ◆ HBM JESD22-A114-A exceeds 2000 V
  - ◆ MM JESD22-A115-A exceeds 200 V
- Specified from −40 °C to +85 °C and from −40 °C to +125 °C

## 3. Ordering information

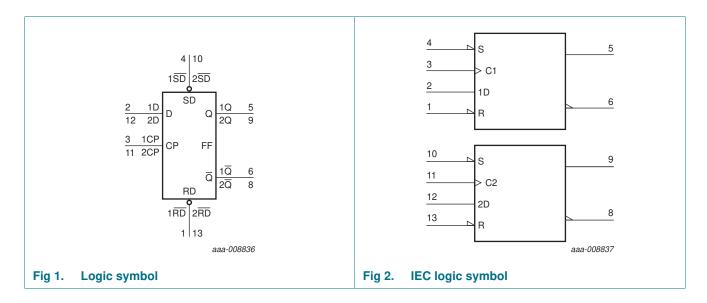
Table 1. Ordering information

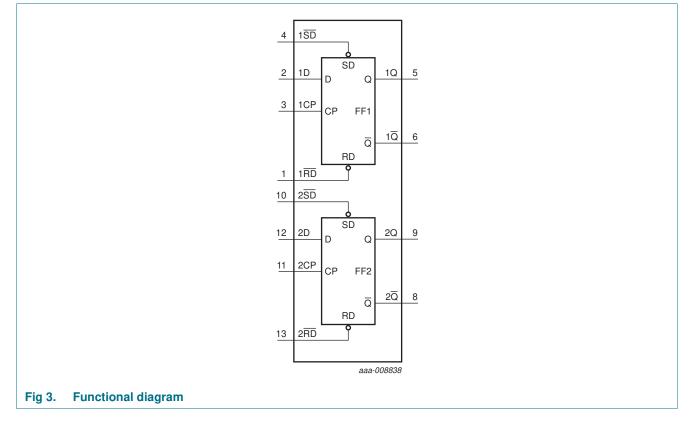
Type number	Package									
	Temperature range	Name	Description	Version						
74LV74N	-40 °C to +125 °C	DIP14	plastic dual in-line package; 14 leads (300 mil)	SOT27-1						
74LV74D	–40 °C to +125 °C	SO14	plastic small outline package; 14 leads; body width 3.9 mm	SOT108-1						
74LV74DB	–40 °C to +125 °C	SSOP14	plastic shrink small outline package; 14 leads; body width 5.3 mm	SOT337-1						
74LV74PW	–40 °C to +125 °C	TSSOP14	plastic thin shrink small outline package; 14 leads; body width 4.4 mm	SOT402-1						



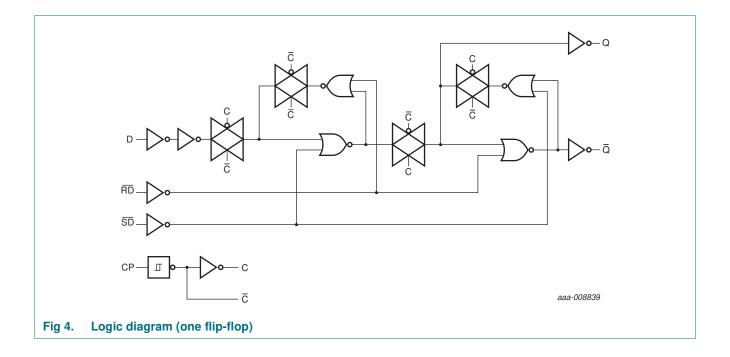
Dual D-type flip-flop with set and reset; positive-edge trigger

## 4. Functional diagram





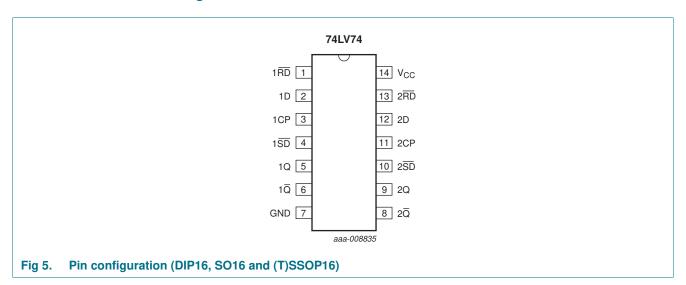
## Dual D-type flip-flop with set and reset; positive-edge trigger



#### Dual D-type flip-flop with set and reset; positive-edge trigger

## 5. Pinning information

#### 5.1 Pinning



## 5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
1RD	1	asynchronous reset-direct input (active-LOW)
1D	2	data inputs
1CP	3	clock input (LOW-to-HIGH), edge-triggered)
1SD	4	asynchronous set-direct input (active-LOW)
1Q	5	true flip-flop outputs
1Q	6	complement flip-flop outputs
GND	7	ground (0 V)
2Q	8	complement flip-flop outputs
2Q	9	true flip-flop outputs
2SD	10	asynchronous set-direct input (active-LOW)
2CP	11	clock input (LOW-to-HIGH), edge-triggered)
2D	12	data inputs
2RD	13	asynchronous reset-direct input (active-LOW)
V <sub>CC</sub>	14	supply voltage

#### Dual D-type flip-flop with set and reset; positive-edge trigger

## 6. Functional description

Table 3. Function table[1]

					Output				
nSD	nRD	nCP	nD	nQ	nQ	Q <sub>n+1</sub>	nQ <sub>n+1</sub>		
L	Н	X	Χ	Н	L	-	·-		
Н	L	Х	Χ	L	Н	-	-		
L	L	Х	Χ	Н	Н	-	-		
Н	Н	<b>↑</b>	L	-	-	L	Н		
Н	Н	<b>↑</b>	Н	-	-	Н	L		

<sup>[1]</sup> H = HIGH voltage level;

### 7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V)

Parameter	Conditions		Min	Max	Unit
supply voltage		[1]	-0.5	+7	V
input clamping current	$V_I < -0.5 \text{ V or } V_I > V_{CC} + 0.5 \text{ V}$		-	20	mA
input voltage		[1]	-0.5	+7	V
output clamping current	$V_O > V_{CC}$ or $V_O < 0$		-	±50	mA
output current	$-0.5 \text{ V} < \text{V}_{\text{O}} < \text{V}_{\text{CC}} + 0.5 \text{ V}$		-	±25	mA
supply current			-	±50	mA
ground current			-	±50	mA
storage temperature			-65	+150	°C
total power dissipation	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } +125  ^{\circ}\text{C}$				
	DIP16 package	[	2] _	750	mW
	SO16 package	]	3] _	500	mW
	(T)SSOP16 package	]	<u>4]</u> _	400	mW
	supply voltage input clamping current input voltage output clamping current output current supply current ground current storage temperature	supply voltage input clamping current $V_I < -0.5 \text{ V or } V_I > V_{CC} + 0.5 \text{ V}$ input voltage output clamping current $V_O > V_{CC}$ or $V_O < 0$ output current $-0.5 \text{ V} < V_O < V_{CC} + 0.5 \text{ V}$ supply current ground current storage temperature total power dissipation $T_{amb} = -40 \text{ °C to } +125 \text{ °C}$ DIP16 package SO16 package	supply voltage	supply voltage $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	supply voltage       I1 $-0.5$ $+7$ input clamping current $V_1 < -0.5 \text{ V or } V_1 > V_{CC} + 0.5 \text{ V}$ -       20         input voltage       I1 $-0.5$ $+7$ output clamping current $V_0 > V_{CC}$ or $V_0 < 0$ - $\pm 50$ output current $-0.5 \text{ V} < V_0 < V_{CC} + 0.5 \text{ V}$ - $\pm 25$ supply current       - $\pm 50$ ground current       - $\pm 50$ storage temperature       - $-65$ $+150$ total power dissipation $T_{amb} = -40 \text{ °C to } +125 \text{ °C}$ DIP16 package       I2       - $-750$ SO16 package       I3       - $-500$

<sup>[1]</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

L = LOW voltage level;

X = don't care;

<sup>↑ =</sup> LOW-to-HIGH clock transition;

 $Q_{n+1}$  = state after the next LOW-to-HIGH CP transition

<sup>[2]</sup>  $P_{tot}$  derates linearly with 12 mW/K above 70 °C.

<sup>[3]</sup>  $P_{tot}$  derates linearly with 8 mW/K above 70 °C.

<sup>[4]</sup> Ptot derates linearly with 5.5 mW/K above 60 °C.

#### Dual D-type flip-flop with set and reset; positive-edge trigger

## 8. Recommended operating conditions

Table 5. Recommended operating conditions

Voltages are referenced to GND (ground = 0 V)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{CC}$	supply voltage <sup>[1]</sup>		1.0	3.3	5.5	V
VI	input voltage		0	-	$V_{CC}$	V
V <sub>O</sub>	output voltage		0	-	$V_{CC}$	V
T <sub>amb</sub>	ambient temperature		-40	-	+125	°C
$\Delta t/\Delta V$	input transition rise and fall rate	$V_{CC} = 1.0 \text{ V to } 2.0 \text{ V}$	0	-	500	ns/V
		$V_{CC} = 2.0 \text{ V to } 2.7 \text{ V}$	0	-	200	ns/V
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	0	-	100	ns/V
		$V_{CC} = 3.6 \text{ V to } 5.5 \text{ V}$	0	-	50	ns/V

<sup>[1]</sup> LV is guaranteed to function down to  $V_{CC}$  = 1.0 V (input levels GND or  $V_{CC}$ ); DC characteristics are guaranteed from  $V_{CC}$  = 1.2 V to  $V_{CC}$  = 5.5 V.

## Dual D-type flip-flop with set and reset; positive-edge trigger

## 9. Static characteristics

Table 6. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	-40	°C to +8	85 °C	-40 °C to	+125 °C	Unit
			Min	Typ[1]	Max	Min	Max	
V <sub>IH</sub>	HIGH-level	V <sub>CC</sub> = 1.2 V	0.9	-	-	0.9	-	V
	input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.4	-	-	1.4	-	V
		V <sub>CC</sub> = 2.7 V to 3.6 V	2.0	-	-	2.0	-	V
		$V_{CC} = 4.5 \ V \text{ to } 5.5 \ V$	$0.7 \times V_{CC}$	-	-	$0.7 \times V_{CC}$	-	V
$V_{IL}$	LOW-level	V <sub>CC</sub> = 1.2 V	-	-	0.3	-	0.3	V
	input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	-	0.6	-	0.6	V
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	-	-	8.0	-	0.8	V
		$V_{CC} = 4.5 \ V \text{ to } 5.5 \ V$	-	-	$0.3 \times V_{\text{CC}}$	-	$0.3 \times V_{CC}$	
$V_{OH}$	HIGH-level	$V_I = V_{IH}$ or $V_{IL}$ ; $I_O = -100~\mu A$						
	output voltage	V <sub>CC</sub> = 1.2 V	-	1.2		-		
		$V_{CC} = 2.0 \text{ V}$	1.8	2.0	-	1.8	-	V
		$V_{CC} = 2.7 \text{ V}$	2.5	2.7	-	2.5	-	V
		$V_{CC} = 3.0 \text{ V}$	2.8	3.0	-	2.8	-	V
		$V_{CC} = 4.5 \text{ V}$	4.3	4.5	-	4.3	-	V
		standard outputs: $V_I = V_{IH}$ or $V_{IL}$						
		$V_{CC} = 3.0 \text{ V}; I_{O} = -6 \text{ mA}$	2.40	2.82	-	2.20	-	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = -12 \text{ mA}$	3.60	4.20	-	3.50	-	V
$V_{OL}$	LOW-level	$V_I = V_{IH}$ or $V_{IL};  I_O = 100 \; \mu A$						
	output voltage	$V_{CC} = 1.2 \text{ V}$	-	0	-	-	-	
		$V_{CC} = 2.0 \text{ V}$	-	0	0.2		0.2	V
		$V_{CC} = 2.7 \text{ V}$	-	0	0.2		0.2	V
		$V_{CC} = 3.0 \text{ V}$	-	0	0.2		0.2	V
		$V_{CC} = 4.5 \text{ V}$	-	0	0.2		0.2	V
		standard outputs: $V_I = V_{IH}$ or $V_{IL}$						
		$V_{CC} = 3.0 \text{ V}; I_O = 6 \text{ mA}$	-	0.25	0.40	-	0.50	V
		$V_{CC} = 4.5 \text{ V}; I_{O} = 12 \text{ mA}$	-	0.35	0.55	-	0.65	V
l <sub>1</sub>	input leakage current	$V_1 = V_{CC}$ or GND; $V_{CC} = 5.5 \text{ V}$	-	-	±1	-	±1	μА
I <sub>CC</sub>	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 5.5 \text{ V}$	-	-	20	-	80	μΑ
$\Delta I_{CC}$	additional supply current	$VI = V_{CC} - 0.6 V;$ $V_{CC} = 2.7 V \text{ to } 3.6 V$	-	-	500	-	850	μΑ
Cı	input capacitance		-	3.5	-			pF

<sup>[1]</sup> Typical values are measured at  $T_{amb}$  = 25 °C.

Dual D-type flip-flop with set and reset; positive-edge trigger

## 10. Dynamic characteristics

Table 7. Dynamic characteristics

GND (ground = 0 V): for test circuit, see Figure 8

Symbol	Parameter	Conditions		-40	°C to +8	5 °C	-40 °C to	+125 °C	Unit
				Min	Typ[1]	Max	Min	Max	
t <sub>pd</sub>	propagation	nCP to nQ, $n\overline{Q}$ ; see Figure 6	[2]		·				·
	delay	V <sub>CC</sub> = 1.2 V		-	70	-	-	-	ns
		V <sub>CC</sub> = 2.0 V		-	24	44	-	56	ns
		$V_{CC} = 2.7 \text{ V}$		-	18	28	-	41	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	[3]	-	13	26	-	33	ns
		$V_{CC} = 3.3 \text{ V}; C_L = 15 \text{ pF}$		-	11	-	-	-	ns
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	[4]	-	9.5	17	-	23	ns
		$n\overline{SD}$ to $nQ$ , $n\overline{Q}$ ; see Figure 7							
		V <sub>CC</sub> = 1.2 V		-	90	-	-	-	ns
		$V_{CC} = 2.0 \text{ V}$		-	31	46	-	58	ns
		$V_{CC} = 2.7 \text{ V}$		-	23	34	-	43	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	[3]	-	17	27	-	34	ns
		$V_{CC} = 3.3 \text{ V}; C_L = 15 \text{ pF}$		-	14	-	-	-	ns
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	[4]	-	12	19	-	24	ns
		nRD to nQ, nQ; see Figure 7							
		V <sub>CC</sub> = 1.2 V		-	90	-	-	-	ns
		$V_{CC} = 2.0 \text{ V}$		-	31	46	-	58	ns
		$V_{CC} = 2.7 \text{ V}$		-	23	34	-	43	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	[3]	-	17	27	-	34	ns
		$V_{CC} = 3.3 \text{ V}; C_L = 15 \text{ pF}$		-	14	-	-	-	ns
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	[4]	-	12	19	-	24	ns
t <sub>W</sub>	pulse width	nCP input HIGH to LOW; see Figure 6							
		$V_{CC} = 2.0 \text{ V}$		34	10	-	41	-	ns
		$V_{CC} = 2.7 \text{ V}$		25	8	-	30	-	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	[3]	20	7	-	24	-	ns
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	<u>[4]</u>	15	6	-	18	-	ns
		nSD or nRD pulse width LOW; see Figure 7							
		V <sub>CC</sub> = 2.0 V		34	10	-	41	-	ns
		V <sub>CC</sub> = 2.7 V		25	8	-	30	-	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	[3]	20	7	-	24	-	ns
		V <sub>CC</sub> = 4.5 V to 5.5 V	[4]	15	6	-	18	-	ns

#### Dual D-type flip-flop with set and reset; positive-edge trigger

**Table 7. Dynamic characteristics** ...continued GND (ground = 0 V): for test circuit, see <u>Figure 8</u>

Symbol	Parameter	Conditions		-40	°C to +8	5 °C	-40 °C t	o +125 °C	Unit
				Min	Typ[1]	Max	Min	Max	
t <sub>rec</sub>	recovery time	nRD; see Figure 7							
		V <sub>CC</sub> = 1.2 V		-	5	-	-	-	ns
		$V_{CC} = 2.0 \text{ V}$		14	2	-	15	-	ns
		$V_{CC} = 2.7 \text{ V}$		10	1	-	11	-	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	[3]	8	1	-	9	-	ns
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	[4]	6	1	-	7	-	ns
t <sub>su</sub>	set-up time	nD to nCP; see Figure 6							
		V <sub>CC</sub> = 1.2 V		-	10	-	-	-	ns
		V <sub>CC</sub> = 2.0 V		22	4	-	26	-	ns
		$V_{CC} = 2.7 \text{ V}$		12	3	-	15	-	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	[3]	8	2	-	10	-	ns
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	[4]	6	1	-	8	-	ns
t <sub>h</sub>	hold time	nD to nCP; see Figure 6							
	noid time	V <sub>CC</sub> = 1.2 V		-	-10	-	-	-	ns
		V <sub>CC</sub> = 2.0 V		3	-2	-	3	-	ns
		$V_{CC} = 2.7 \text{ V}$		3	-2	-	3	-	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$		3	-2	-	3	-	ns
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		3	-2	-	3	-	ns
f <sub>max</sub>	maximum	nCP; see Figure 6							
	frequency	V <sub>CC</sub> = 2.0 V		14	40	-	12	-	MHz
		$V_{CC} = 2.7 \text{ V}$		50	90	-	40	-	MHz
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	[3]	60	100	-	48	-	MHz
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	[4]	70	110	-	56	-	MHz
$C_{PD}$	power dissipation capacitance	$V_I = GND$ to $V_{CC}$	<u>[5]</u>	-	24	-	-	-	pF

<sup>[1]</sup> Typical values are measured at  $T_{amb} = 25$  °C.

f<sub>o</sub> = output frequency in MHz;

 $\Sigma (C_L \times V_{CC}^2 \times f_o) = \text{sum of outputs};$ 

 $C_L$  = output load capacitance in pF;

V<sub>CC</sub> = supply voltage in V.

<sup>[2]</sup>  $t_{pd}$  is the same as  $t_{PHL}$  and  $t_{PLH}$ .

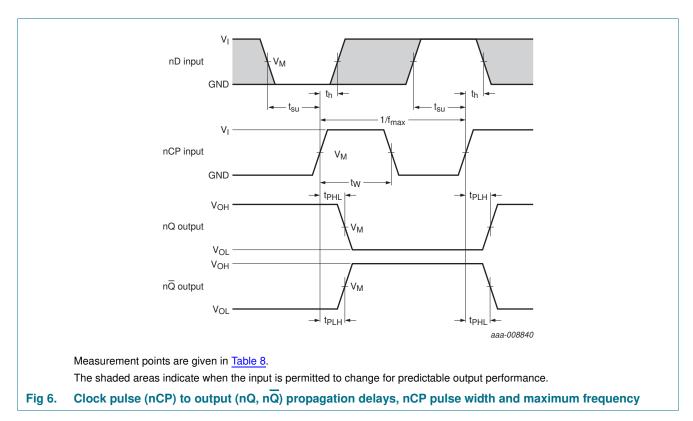
<sup>[3]</sup> Typical value measured at  $V_{CC}$  = 3.3 V.

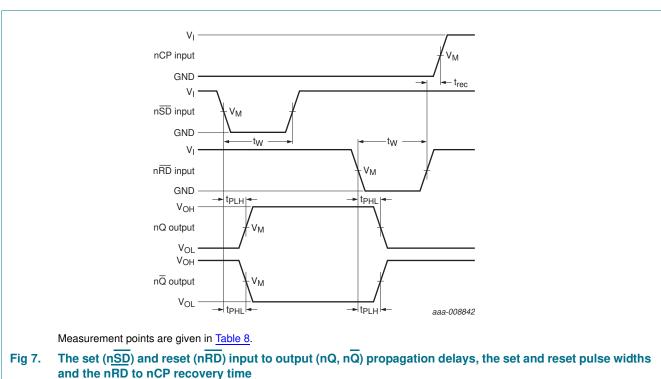
<sup>[4]</sup> Typical values are measured at  $V_{CC}$  = 5.0 V.

<sup>[5]</sup>  $C_{PD}$  is used to determine the dynamic power dissipation  $P_D = C_{PD} \times V_{CC}^2 \times f_i + \Sigma (C_L \times V_{CC}^2 \times f_o)$  ( $P_D$  in  $\mu$ W), where:  $f_i$  = input frequency in MHz;

#### Dual D-type flip-flop with set and reset; positive-edge trigger

#### 11. Waveforms

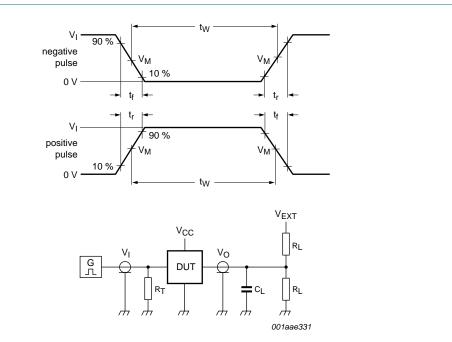




#### Dual D-type flip-flop with set and reset; positive-edge trigger

Table 8. Measurement points

Supply voltage	Input	Output
V <sub>CC</sub>	V <sub>M</sub>	V <sub>M</sub>
< 2.7 V	0.5V <sub>CC</sub>	0.5V <sub>CC</sub>
2.7 V to 3.6 V	1.5 V	1.5 V
≥ 4.5 V	0.5V <sub>CC</sub>	0.5V <sub>CC</sub>



Test data is given in Table 9.

Definitions for test circuit:

 $R_L$  = Load resistance.

C<sub>L</sub> = Load capacitance including jig and probe capacitance.

 $R_T$  = Termination resistance should be equal to output impedance  $Z_o$  of the pulse generator.

 $V_{\text{EXT}}$  = External voltage for measuring switching times.

Fig 8. Test circuit for measuring switching times

Table 9. Test data

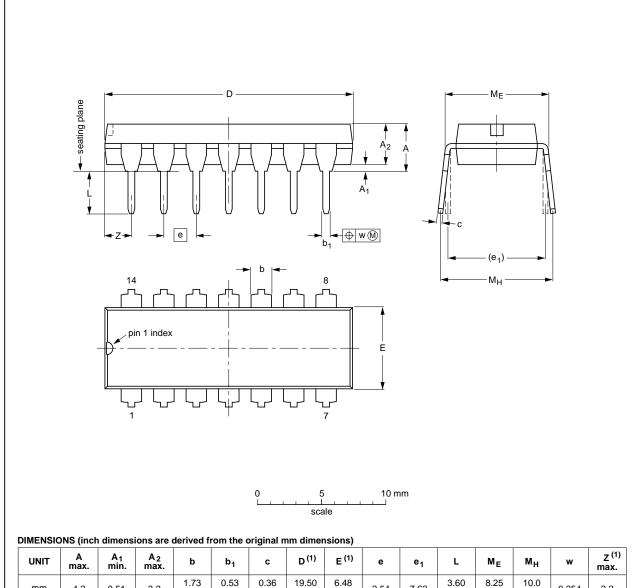
Supply voltage	Input		Load	Load		
	VI	t <sub>r</sub> , t <sub>f</sub>	C <sub>L</sub>	$R_L$	t <sub>PHL</sub> , t <sub>PLH</sub>	
< 2.7 V	$V_{CC}$	2.5 ns	50 pF	1 kΩ	open	
2.7 V to 3.6 V	2.7 V	2.5 ns	50 pF, 15 pF	1 kΩ	open	
≥ 4.5 V	$V_{CC}$	2.5 ns	50 pF	1 kΩ	open	

#### Dual D-type flip-flop with set and reset; positive-edge trigger

## 12. Package outline

#### DIP14: plastic dual in-line package; 14 leads (300 mil)

SOT27-1



UNIT	A max.	A <sub>1</sub> min.	A <sub>2</sub> max.	b	b <sub>1</sub>	С	D <sup>(1)</sup>	E <sup>(1)</sup>	е	e <sub>1</sub>	L	ME	Мн	w	Z <sup>(1)</sup> max.
mm	4.2	0.51	3.2	1.73 1.13	0.53 0.38	0.36 0.23	19.50 18.55	6.48 6.20	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.2
inches	0.17	0.02	0.13	0.068 0.044	0.021 0.015	0.014 0.009	0.77 0.73	0.26 0.24	0.1	0.3	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.087

#### Note

1. Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT27-1	050G04	MO-001	SC-501-14			<del>99-12-27</del> 03-02-13

Fig 9. Package outline SOT27-1 (DIP14)

4LV74

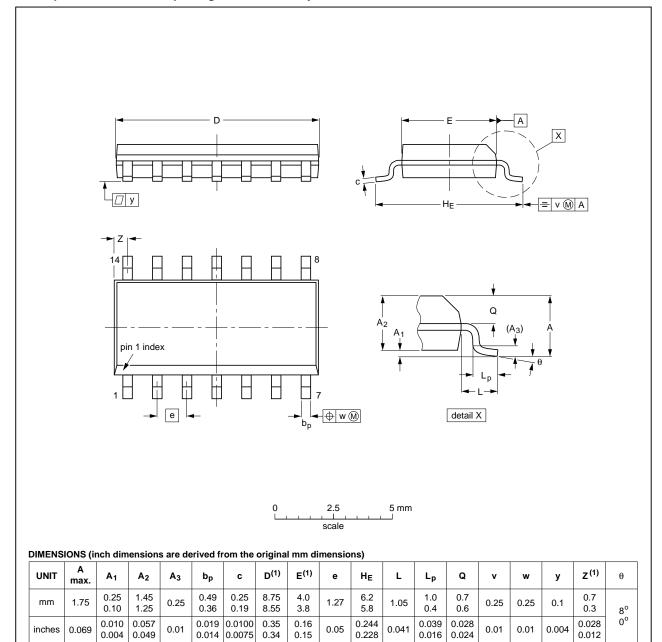
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#### Dual D-type flip-flop with set and reset; positive-edge trigger

SO14: plastic small outline package; 14 leads; body width 3.9 mm

SOT108-1



## Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE	
SOT108-1	076E06	MS-012			<del>99-12-27</del> 03-02-19	

Fig 10. Package outline SOT108-1 (SO14)

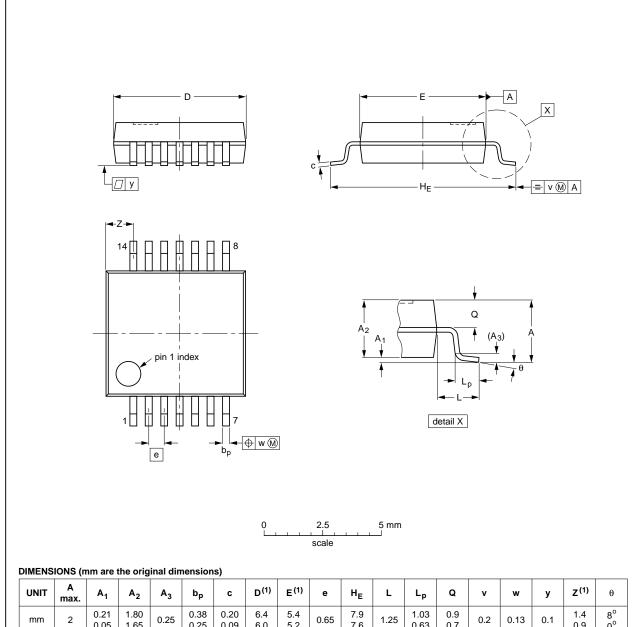
4LV74

74LV74 **NXP Semiconductors** 

#### Dual D-type flip-flop with set and reset; positive-edge trigger

SSOP14: plastic shrink small outline package; 14 leads; body width 5.3 mm

SOT337-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E <sup>(1)</sup>	е	HE	L	Lp	Q	v	w	у	Z <sup>(1)</sup>	θ
mm	2	0.21 0.05	1.80 1.65	0.25	0.38 0.25	0.20 0.09	6.4 6.0	5.4 5.2	0.65	7.9 7.6	1.25	1.03 0.63	0.9 0.7	0.2	0.13	0.1	1.4 0.9	8° 0°

#### Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE	
SOT337-1		MO-150			<del>99-12-27</del> 03-02-19	

Fig 11. Package outline SOT337-1 (SSOP14)

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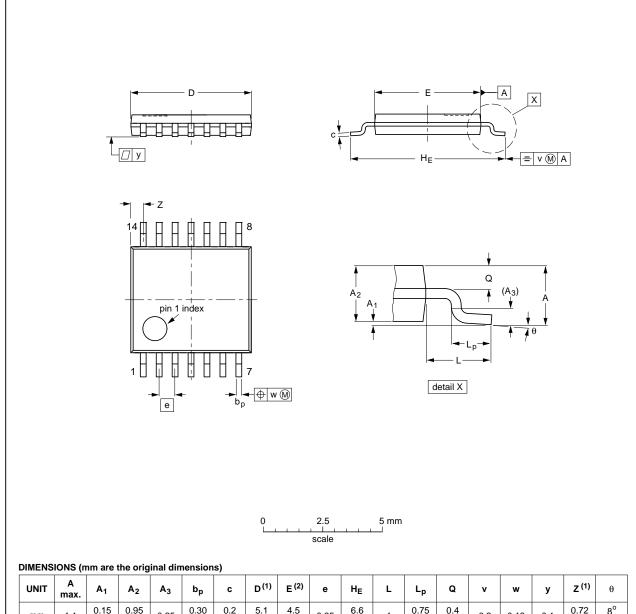
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74LV74 **NXP Semiconductors** 

#### Dual D-type flip-flop with set and reset; positive-edge trigger

TSSOP14: plastic thin shrink small outline package; 14 leads; body width 4.4 mm

SOT402-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E (2)	е	HE	L	Lp	Q	v	w	у	Z <sup>(1)</sup>	θ	
mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	5.1 4.9	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.72 0.38	8° 0°	

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE	
SOT402-1		MO-153			<del>99-12-27</del> 03-02-18	

Fig 12. Package outline SOT402-1 (TSSOP14)

#### Dual D-type flip-flop with set and reset; positive-edge trigger

## 13. Abbreviations

#### Table 10. Abbreviations

Acronym	Description
CMOS	Complementary Metal-Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
НВМ	Human Body Model
MM	Machine Model
TTL	Transistor-Transistor Logic

## 14. Revision history

#### Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes					
74LV74 v.3	20130909	Product data sheet	-	74LV74_CNV v.2					
Modifications:	<ul> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> </ul>								
	<ul> <li>Legal texts have been adapted to the new company name where appropriate.</li> </ul>								
	<ul> <li>Family data</li> </ul>	added, see Section 9 "Sta	tic characteristics"						
74LV74_CNV v.2	April 1998	Product specification	-	-					

#### Dual D-type flip-flop with set and reset; positive-edge trigger

## 15. Legal information

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Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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74LV74

#### Dual D-type flip-flop with set and reset; positive-edge trigger

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